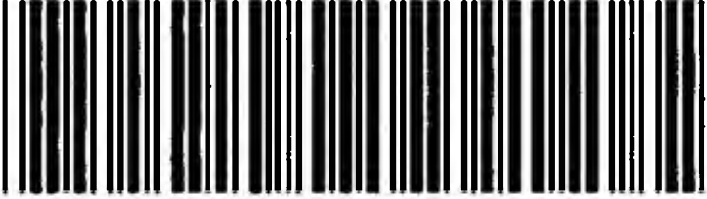


<div>Search Notes</div> <div></div>	<div>Application/Control No.</div> <div>10542163</div>	<div>Applicant(s)/Patent Under Reexamination</div> <div>KIDA, AKIRA</div>
	<div>Examiner</div> <div>Tynan, Matthew</div>	<div>Art Unit</div> <div>2871</div>

SEARCHED			
Class	Subclass	Date	Examiner
349	58-60	3/1/2007	MT
349	58-60, 161	8/2/2007	MT
349	58-60, 161	11/2/2007	MT

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted A. Schechter	3/1/07	MT
Consulted A. Schechter	8/2/2007	MT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner